

PCI Express Connector

1. INTRODUCTION

1.1. Purpose

Testing was performed on the TE PCI Express connector to determine its conformance to the requirements of Product Specification 108-57375, Revision B.

1.2. Scope

This report covers the electrical, mechanical, and environmental performance of the PCI Express connector.

1.3. Conclusion

The PCI Express connector listed in paragraph 1.5. conformed to the electrical, mechanical, and environmental performance requirements of Product Specification 108-57375, Revision A.

1.4. Product Description

The PCI Express connector is used in PCIor PCI-based systems, supporting x1, x4, x8, and x16 link widths to suit different bandwidth requirements. These connectors support the PCI Express signal and power requirements, as well as auxiliary signals used to facilitate the interface between motherboard and add-in card hardware.

1.5. Test Specimens

Test specimens were representative of normal production lots. The following specimens were used for test.

Test Group	Quantity	Description
A, B, C, D, E, F, G, H 8 pcs		PCI Express Connector 1X~16X

DR		DATE	APVD	DATE
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1.6. Qualification Test Sequence

	Test Group								
(c)Test or Examination	Α	В	С	D	E	F	G (c)	Н	l (c)
	Test Sequence (a)								
Examination of product.	1, 9	1, 8	1, 10	1, 8	1, 8	1, 3	1, 3	1, 3	1, 3
Low level contact resistance.	3, 7	2, 5, 7	2, 5, 7, 9	2, 5, 7					
Dielectric withstanding voltage.					2, 6				
Insulation resistance.					3, 7				
Mating force.	2, 6								
Unmating force.	4, 8								
Durability.	5	3	3	3					
Reseating.		6	8						
Vibration, random.				6 (b)					
Solderability.						2			
Resistance to wave soldering heat.							2		
Resistance to reflow soldering heat									2
Temperature life.		4							
Temperature life (Preconditioning).				4					
Thermal shock.			4		4				
Humidity-temperature cycling.			6		5				
Contact current rating/ Temperature rise.								2	

NOTE

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 $(a\,)\,$ Numbers indicate sequence in which tests are performed.

(b) Discontinuities shall not take place in this test group, during tests.

(c) Resistance to soldering process is indicated on notes of customer drawing. Select the appropriate test type which drawing notes are matched with.

Figure 1



2. TEST RESULT

Test				Test I				
Test Group	Test Description	Requirement	Max.	Min.	Ave.	Std. Dev.	Judgment	
	Examination of product.	Meets product drawing.	PASSED				Accepted	
А	Mating force.	1.15 N/contact pair max.		0.43	0.47	0.02	Accepted	
	Low level contact resistance.	30 mΩ max.	16.42	10.36	13.31	1.68	Accepted	
	Unmating force.	0.15 N/contact pair min.	0.31	0.22	0.26	0.03	Accepted	
	Durability.	No damage.		PAS	SED		Accepted	
	Mating force.	1.15 N/contact pair max.	0.46	0.41	0.43	0.02	Accepted	
	Low level contact resistance.	30 mΩ max.	27.18	19.50	22.83	2.20	Accepted	
	Unmating Force.	0.15 N/contact pair min.	0.33	0.23	0.28	0.03	Accepted	
	Examination of product.	Meets product drawing.	PASSED				Accepted	
	Examination of product.	Meets product drawing.	· · ·				Accepted	
	Low level contact resistance.	30 mΩ max.	11.37	8.88	9.21	0.91	Accepted	
	Durability.	No damage.		PAS	SED		Accepted	
В	Temperature life.	No damage.	PASSED				Accepted	
В	Low level contact resistance.	30 mΩ max.	15.37	11.25	14.31	1.89	Accepted	
	Reseating.	No damage.	PASSED			Accepted		
	Low level contact resistance.	30 m+Ω max.	16.68	11.34	14.96	2.72	Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted		
	Examination of product.	Meets product drawing.	PASSED			Accepted		
	Low level contact resistance.	30 mΩ Max.	9.36	7.14	8.03	0.76	Accepted	
	Durability.	No damage.	PASSED				Accepted	
	Thermal shock.	No damage.	PASSED			Accepted		
С	Low level contact resistance.	30 mΩ Max.	11.25	9.04	9.94	0.92	Accepted	
Ŭ	Humidity-temperature cycling.	No damage.	PASSED				Accepted	
	Low level contact resistance.	30 mΩ max.	12.64	9.55	11.34	1.40	Accepted	
	Reseating.	No damage.	PASSED			Accepted		
	Low level contact resistance.	30 mΩ max.	13.77 10.06 11.67 1.62			Accepted		
	Examination of product.	Meets product drawing.	PASSED				Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted		
	Low level contact resistance.	30 mΩ Max.	11.56	8.97	9.64	0.72	Accepted	
D	Durability.	No damage.	PASSED			Accepted		
	Temperature life (Preconditioning).	No damage.		PASSED		Accepted		
	Low level contact resistance.	30 mΩ max.	14.74 11.16 12.88 1.28			Accepted		
	Vibration, random.	No discontinuities of 1 µs or longer duration.	PASSED			Accepted		
	Low level contact resistance.	30 mΩ max.	15.89	12.30	13.64	1.41	Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted		

Figure 2 (continued)



Test				Test F			
Group	Test Description	Requirement	Max.	Min.	Ave.	Std. Dev.	Judgment
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Dielectric withstanding voltage.	No breakdown or flashover.		PASSED			Accepted
	Insulation resistance.	1000 MΩ Min.	PASSED				Accepted
Е	Thermal shock.	No damage.	PASSED			Accepted	
	Humidity-temperature cycling.	No damage.	PASSED			Accepted	
	Dielectric withstanding voltage.	No breakdown or flashover.		P`AS	SED		Accepted
	Insulation resistance.	1000 MΩ Min.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Examination of product.	Meets product drawing. PASSED				Accepted	
F	Solderability.	95% solder coverage min.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted	
G	Resistance to wave solder heat.	No damage.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Examination of product.	Meets product drawing.		PAS	SED		Accepted
н	Contact current rating/ Temperature rise.	Less than 30°C temp rise.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED				Accepted
I	Examination of product.	Meets product drawing.		PAS	Accepted		
	Resistance to reflow solder heat.	No damage. PASSED			Accepted		
	Examination of product.	Meets product drawing.	PASSED				Accepted

Figure 2 (end)